

Notice of References Cited

Application/Control No.		Applicant(s)/Pate	ent Under
10/074,081	r	Reexamination SUN, CHEN	
Examiner		Art Unit	· ·
Cam Y T Truong		2172	Page 1 of 1

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	С	US-6,457,047	09-2002	Chandra et al.	709/217
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